Brammer Standard Company, Inc.

Certificate of Analysis

BS T-2A

Certified Reference Material¹ for Grade 2 Commercially Pure Titanium (UNS Number R50400, ASTM B348(2))

	Certified Value ²	Estimate of Uncertainty ³	Informatio	Information Values ⁴						
		Analysis listed as percent by weight								
AI	0.005	0.001	С	0.007						
Cr	0.018	0.0015	Cu	0.001						
Fe	0.156 ⁵	0.008	Н	0.0020						
Mn	0.003	0.0005	Ν	0.0044						
Мо	0.002	0.0005	0	0.12						
Ni	0.021	0.002	S	0.0004						
Si	0.002	0.0008								
Sn	0.006	0.0015								
v	<0.002									
w	<0.002									
Zr	<0.003									

¹ Brammer Standard Company, Inc., is accredited by A2LA (Certificate Number 656.02) to ISO Guide 34 as a Reference Material Producer to produce Certified Reference Materials.

² The certified value listed is the present best estimate of the true value based on the results of an interlaboratory testing program.

 3 The uncertainties listed are based on value judgments of the material inhomogeneity and the 95% confidence interval. The half-width confidence interval C(95%) is shown on page 2.

⁴ Information values are not certified and are provided for information only.

⁵ The original Fe value of 0.157% certified on December 14, 2001 was revised to 0.156% after an additional laboratory reported their results.

See the following pages for more information.

Certificate Number RevT2A-012202p1

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BS T2A				Data l	listed	as i	nass fract	tion	exp	ressed a	ıs pe	rcen	t.							Re	vT2A-01	2201	թ2
Analysis	*	Al	*	Cr	*		Fe	*	Mr	1 1	*	Mo		*	N :	i '	 k	Si	*	Sr	1 1	*	V
1 2 3 4 5 6 7 8 9 10 11	AIC AGM AIC AIC AIC AIC AIC AGM AES	$\begin{array}{c} 0.0031\\ 0.00375\\ 0.004\\ 0.0040\\ 0.005\\ 0.005\\ 0.0052\\ 0.0055\\ 0.0055\\ 0.0057\end{array}$	AIC AIC XRF AIC AIC AIC AIC AIC AIX AIC AES AGM	0.016 0.017 0.017 0.017 0.017 0.017 0.017 0.017 0.017 0.018 0.018 0.018 0.018 0.018 0.018	A A A 7 A 8 A 9 A 0 A 6	IC RF IC IC IC ES IC GM	0.141 0.150 0.151 0.153 0.156 0.1608 0.164 0.165 0.165	AI AI AI AI AI AI AI AI AI	C 0. C 0. C 0. C 0. C 0. C 0. S 0. X 0.	.002 .0030 .003 .0031 .0032 .0032 .0032 .0035 .0037 .004	AGM AIC AES AIC AIC AIC AIC AIC AIC AGM		013 018 018 02 020 02 020 02 020 021 028	AIC AIC AIC AGM AIC AIC AIC AIC AIC AIC AIX AES		.018 2 .0190 2 .0200 2 .0215 2 .0215 2 .0216 2 .022 2 .022 4 .022 4 .023 .0234	AIC AGM AIC AIC AGM AES AIC	0.001 0.0017 0.0018 0.002 0.0022 0.003 0.0032	AI(AGI AI(AI(AI(XR: XR: AI(AE)		0 0 4 0 0 0 4 5 0 0 5 0 0 5 0 0 6 0 0 7 0 0 7 0 0 7 0 0 7 4 0 0 7 8	AIC AIC AIC AGM AIC AIC	<0.0006 <0.0006 0.0002 0.00030 0.0006 0.0011
Average		0.0046		0.0178	8		0.1561		0.	.0032		0.0	020		0	.0212		0.0021		0.	.0059		
Std Dev		0.0009		0.0013	3		0.0082		0.	.0005		0.0	004		0	.0016		0.0008		0.	.0013		
Certified		0.005		0.018			0.156		0.	.003		0.0	02		0	.021		0.002		0.	. 0 0 6		<0.002
t 		2.306		2.2281	1 		2.306		2.	.2622		2.2	622		2	.2281		2.4469		2.	.306		
Analysis	*	 W	 *	Zr			с.	*	 Cı	 	*	 н		*	 N			 	*	 S			
1	ATC	<0 001		< 0 00	 0 0 8	ב – – ק ב	S 0 004	1		0 0004	F	 11 0	0.018	 2		0 0035		0 0 9 9			0 0002	 5	
2 3 4 5 6 7 8 9	AIC AIC AIC AIC AGM AIC	<0.001 <0.001 <0.0010 <0.002 0.00011 0.0004	AIC AIC AIC AGM AIC AGM AES AIC	<pre>< < 0.00 < < 0.00 < < 0.00 < 0.00 < 0.00 < 0.00 < 0.00 < 0.00 </pre>	008 01 004 0048 010 0127 017 020	C C C C	0.005 0.005 0.009 0.010 0.011		AGM AIC AGM AIC AIC	0.0006 0.0010 0.0010 0.0018 0.0019	5 F F	U 0 U 0 U 0	.0018	3 F 0 F 1 F F		0.0040 0.0044 0.0046 0.0048 0.005	FU AG FU FU FU FU	M 0.107 0.117 0.118 0.122 0.133 0.140	75 (7 (8 19	2	0.0004	5	
Average							0.007	4		0.0011	3	0	.0019	6		0.00438	3	0.119	91		0.0004	2	
Std Dev							0.003	0		0.0006	1	0	.0001	9		0.00055	5	0.013	39		0.0001	8	
Certified		<0.002		<0.00	03		(0.007)		(0.001)		(0	.0020)		(0.0044)		(0.12))		(0.0004)	
t							2.5700	5		2.5706		3	.1824			2.5706		2.446	59		4.3027		
с(95%)							0.003	2		0.0006	4	0	.0003	0		0.00058	3	0.012	29		0.0004	4	

Data in parentheses are not certified but are provided for information only.

 $C(95\%) = (t \ x \ sd)/\sqrt{n}$ The half-width confidence interval, where t is the appropriate Student's t value, sd is the interlaboratory standard deviation, and n is the number of acceptable mean values. For further information regarding the confidence interval for the certified value see ISO Guide 35:1989 section 4.

* Methods of Analysis

Code	Method									
AES	AES - Spark Source Optical Emission Spectrometry	AES = Atomic Emission Spectrometry								
AIC	AES - ICP -Inductively Coupled Plasma Spectrometry									
AIX	Average of Inductively Coupled Plasma Spectrometry and X-Ray Fluorescence Spectrometry									
AGM	AES - Glow Discharge Mass Spectrometry									
С	Combustion-Infrared Absorption (ASTM E 1019) traceable to CR	Ms								
FU	Inert gas Fusion Method (ASTM E 1019) traceable to CRMs									
XRF	X-Ray Fluorescence Spectrometry									

Co-operating Laboratories: The co-operating laboratories were:

o operating Euseratories. The ee operating haberatories were:	
Laboratory	Laboratory contact
AK Steel Research, Middletown, Ohio	Howard P. Vail
Allegheny Ludlum, Technical Center, Brackenridge, Pennsylvania	Shawn D. Cooper
Allvac, Monroe, North Carolina	Patrick M. Cole
Brammer Standard Co., Inc., Houston, Texas	Richard P. Beaumont
J. Dirats and Co., Inc., Westfield, Massachusetts	Eric E. Dirats
LECO Corporation, St. Joseph, Michigan	Dennis A. Lawrenz
Northern Analytical Laboratory Inc., Merrimack, New Hampshire	Richard J. Guidoboni
Shiva Analyticals (India) Ltd., Hoskote, Bangalore, India	Dr. T. V. Ramakrishna
Titanium Matels Corporation, Morgantown, Pennsylvania	Larry E. Creasy
VHG Laboratories, Inc., Manchester, New Hampshire	Julie M. McIntosh

Certification Process: The requirements of ISO Guide 31, ISO Guide 34, ISO Guide 35, and ASTM Standard Guides E 1724 and E 1831 were followed for the preparation of this reference material and certificate of analysis. This is a Certified Reference Material as defined by ISO Guide 30.

Analysis: Chemical analyses were made on chips prepared by a lathe from the certified portion of the discs. No standardized sampling procedures are available for titanium, but the principles of ASTM Practice 1806 were used to obtain representative test samples. The laboratories participating in the testing normally followed the requirements of ISO Guide 25 and/or ISO Standard 17025. Individual values listed on page 2 are the average of each analyst's results. Methods of analysis are listed on page 2.

Outliers: Some outlying data was excluded from the data listed on page 2 due to technical assessment of the co-operating laboratories and statistical evaluation.

Traceability: The following Certified Reference Materials were used to validate the analytical data listed on page 2: SRM 125b, 131e, 173a, 173b, 348a, 651; CE 031.

Homogeneity: This Certified Reference Material was tested for homogeneity using ASTM Standard Method E 826 and found acceptable. It was also examined by optical emission spectrometry and found to be compatible with the following Reference Materials: BS T2 and T4.

Validity statement: ISO Guide 31 states that the certificate of analysis should contain an expiration date for all materials where instability has been demonstrated or is considered possible, after which the certified value is no longer guaranteed by the certifying body. Whereas this material is in a solid form and stable, no expiration date is specified.

Source: This material was supplied by President Titanium, Hanson, Massachusetts.

Form: This Certified Reference Material is in the form of a disc, approximately 38 mm in diameter and 12 mm thick.

Use: This Certified Reference Material is intended for use in optical emission and x-ray spectrometric methods of analysis. Refer to ISO Guide 33 for information about the use of Reference Materials.

Certified area: The entire depth of the disc may be used.

Caution: As with any bar material, avoid optical emission spectrometric burns in the center of the disc (5 mm radius), as some segregation may be present.

Sample Preparation: For best analytical results, use the same method for preparing the analytical surface on all reference materials as you use for production specimens. Avoid overheating the disc during surface preparation.

Certificate Number: The unique identification number for this certificate of analysis is RevT2A-012201-px, where x indicates the page number. Refer to future Brammer Standard Company catalogs for information on any revisions to this or other Brammer Standard reference materials. You may also obtain information on revisions of certificates from the internet at brammerstandard.com.

Safety Notice: A Material Safety Data Sheet (MSDS) is not required for this material. This material will not release or otherwise result in exposure to a hazardous chemical under normal conditions of use. Inquiries concerning this Reference Material should be directed to:

Brammer Standa	rd Co., Inc.	Phone: (281) 440-9396	web	brammerstandard.com		
14603 Benfer Ro	ad					
Houston, Texas	77069-2895 USA	Fax: (281) 440-4432	e-mail	bramstan@netropolis.net		

Certified by:

______ on January 22, 2002. G. R. Brammer Brammer Standard Company, Inc., is accredited to ISO Guide 34 as a Reference Material Producer for the production of Certified Reference Materials and Reference Materials by A2LA (Certificate Number 656.02) The scope of accreditation is listed on the website: www.brammerstandard.com

By Certificate Number 10539, the Quality System of Brammer Standard Company, Inc., is registered to ISO 9002:1994 by National Quality Assurance, U.S.A.

Brammer Standard Company's Chemical Laboratory is accredited to ISO Guide 25 by A2LA. (Certificate Number 656.01)

References:

ASTM documents available from ASTM, 100 Barr Harbor Drive, West Conshohocken, PA 19428-2959, Telephone: 610-832-9500 Fax: 610-832-9555 e-mail: service@astm.org Website: www.astm.org

B 348 - 98 Standard Specification for Titanium and Titanium Alloy Bars and Billets

DS-56G (SAE HS-1086 Jan99) Metals & Alloys in the Unified Numbering System, 8th Edition

E 826 - 85 (Reapproved 1996) Standard Practice for Testing Homogeneity of Materials for the Development of Reference Materials

E 1019 - 2000 Standard Test Methods for Determination of Carbon, Sulfur, Nitrogen, and Oxygen in Steel and in Iron, Nickel, and Cobalt Alloys

E 1724 - 95 Standard Guide for Testing and Certification of Metal and Metal-Related Reference Materials

E 1806 - 96 Standard Practice for Sampling Steel and Iron for Determination of Chemical Composition

E 1831 - 96 Standard Guide for Preparing Certificates for Reference Materials Relating to Chemical Composition of Metals, Ores, and Related Materials.

ISO Guides available from Global Engineering - www.global.ihs.com

ISO Standard 17025 (First edition, 1999), General requirements for the competence of calibration and testing laboratories.

ISO Guide 25 (Third edition, 1990), General requirements for the competence of calibration and testing laboratories.

ISO Guide 30 (Second edition, 1991), Terms and definitions used in connection with reference materials.

ISO Guide 31 (Second edition, 2000), Reference materials -Contents of certificates and labels.

ISO Guide 33 (Second edition, 2000), Uses of certified reference materials.

ISO Guide 34 (Second edition, 2000), General requirements for the competence of reference material producers.

ISO Guide 35 (Second edition, 1989), Certification of reference materials - General and statistical principles.

Other useful documents available from NIST, U.S. Department of Commerce, Gaithersburg, MD 20899.

NIST Special Publication 260-100, Handbook for SRM Users

NIST Special Publication 829, Use of NIST Standard Reference Materials for Decisions on Performance of Analytical Chemical Methods and Laboratories